



N-Channel Reduced Q_g , Fast Switching MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0075 at V _{GS} = 10 V	21.5	12 nC			
	0.0115 at V _{GS} = 4.5 V	17.4	12110			

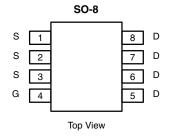
FEATURES

- Extremely Low Q_{gd} for Low Switching Losses
 TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

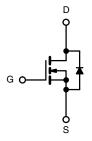


APPLICATIONS

- High-Side DC/DC Conversion
 - Notebook
 - Server



Ordering Information: Si4392ADY-T1-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS (T _A = 25 °C	, unless othe	erwise noted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20		
	T _C = 25 °C		21.5		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	I _D	17.2		
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C		15 ^{b, c}		
	T _A = 70 °C]	11.8 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	50	^	
Continuous Source-Drain Diode Current	T _C = 25 °C	1	5.6		
	T _A = 25 °C	l _S	2.7 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	25		
Avalanche Energy		E _{AS}	31	mJ	
	T _C = 25 °C	P _D	6.25		
Maximum Power Dissipation	T _C = 70 °C		4.0	w	
	T _A = 25 °C		3.0 ^{b, c}	V V	
	T _A = 70 °C		1.9 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	33	42	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{th,IF}$	16	20	0/11	

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 90 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•			•			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		30		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 6			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	1.0		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μΑ	
		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain Source On State Begintance ^a	_	V _{GS} = 10 V, I _D = 12.5 A		0.006	0.0075	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.009	0.0115		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 12.5 A		46		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1465		pF	
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		360			
Reverse Transfer Capacitance	C _{rss}			150			
Tatal Cata Chayera	Qg	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12.5 \text{ A}$		25	38	nC	
Total Gate Charge				12	18		
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 12.5 \text{ A}$		3.7			
Gate-Drain Charge	Q_{gd}			3.1			
Gate Resistance	R_{g}	f = 1 MHz		1.9	2.9	Ω	
Turn-on Delay Time	t _{d(on)}			16	25	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		50	75		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		21	32		
Fall Time	t _f			8	15		
Turn-on Delay Time	t _{d(on)}			8	15		
Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		35	55		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		23	35		
Fall Time	t _f			8	15		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			5.6	Α	
Pulse Diode Forward Current ^a	I _{SM}				50		
Body Diode Voltage	V _{SD}	$I_{S} = 2.7 \text{ A}$		0.73	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			26	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L_ = 10 A dl/dt = 100 A/us T = 25 °C		19	30	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		13		ns	
Reverse Recovery Rise Time	t _b			13			

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

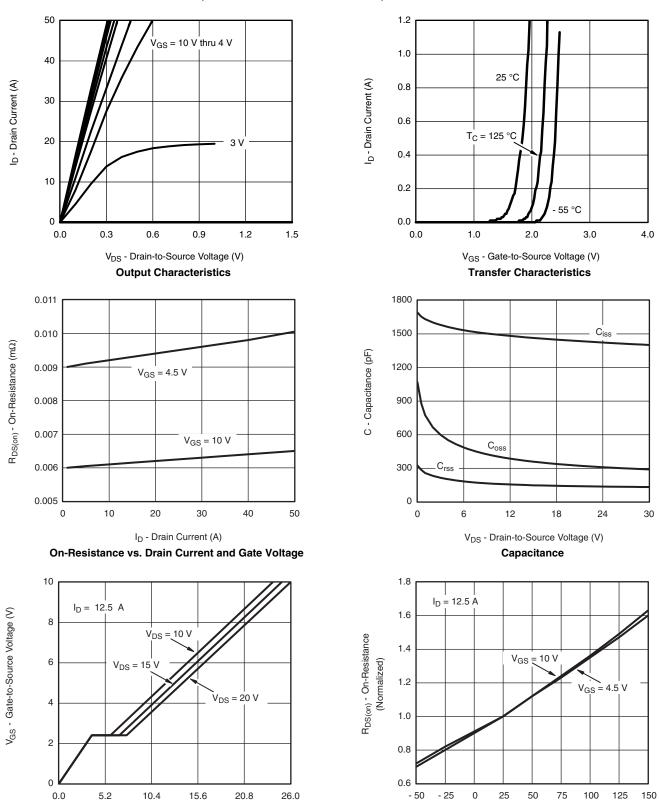
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

b. Guaranteed by design, not subject to production testing.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Q_g - Total Gate Charge (nC)

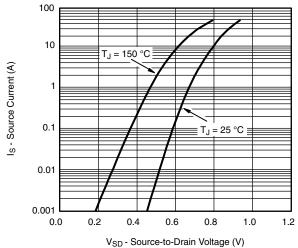
Gate Charge

T_J - Junction Temperature (°C)

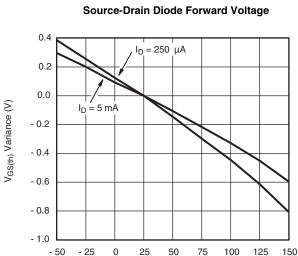
On-Resistance vs. Junction Temperature

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



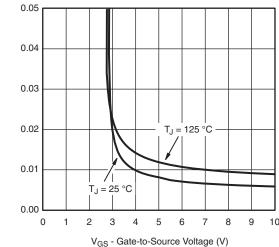




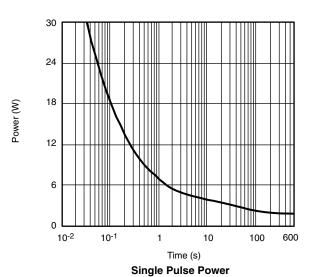
T_J - Temperature (°C)

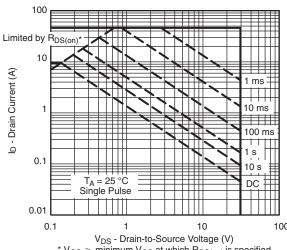
Threshold Voltage

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - Drain-to-Source On-Resistance (Ω)



On-Resistance vs. Gate-to-Source Voltage



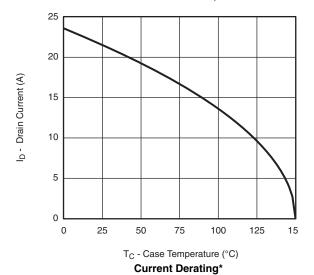


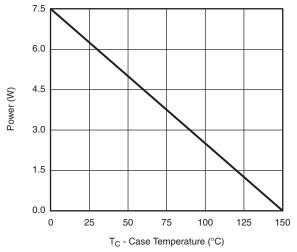
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified Safe Operating Area, Junction-to-Ambient



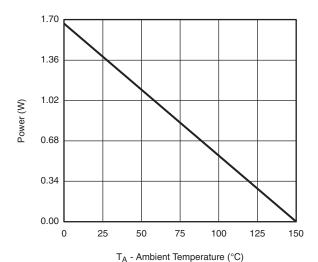


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Power Derating, Junction-to-Foot



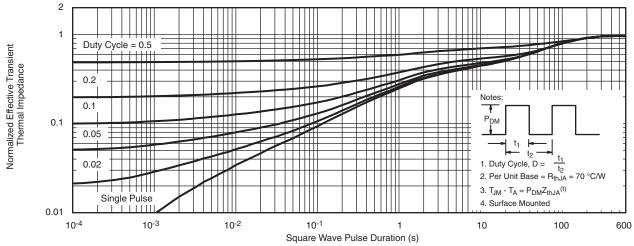
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

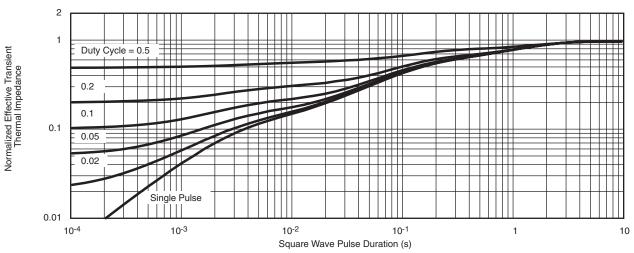
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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